Supplementary materials:

Broad temperature plateau for high ZTs in heavily doped p-type

SnSe single crystals[†]

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X-ray diffraction patterns (XRD)



Figure S1a. XRD patterns of $Sn_{1-x}R_xSe$ (R=Ag, Na; x=0, 0.01, 0.02, 0.03) along the cleavage plane, and the simulated diffraction pattern. **Figure S1b.** X-ray diffraction patterns of $Sn_{1-x}R_xSe$ (R=Ag, Na; x=0, 0.01, 0.02, 0.03) powder.

Figure S1a displays the XRD patterns of Sn_{1-x}R_xSe (R=Ag, Na; x=0, 0.01, 0.02, 0.03) single crystals along the cleavage plane. The (400) and (800) planes confirm that the Sn_{1-x}R_xSe crystals are cleaved along the b-c plane. The as-prepared single crystals were then pulverized and X-ray diffraction characterization on an *X'Pert³ Powder (Panalytic)* using Cu Ka (λ =1.5418 Å) radiation was carried out as shown in Figure S1b, a pure SnSe phase with *Pnma* space group was obtained in our study. Lattice parameters as function of different contents of the dopant are shown in Table S1. The volume of the unit cell of doped crystals is slightly larger than that of the undoped crystal. Moreover, the cell volume of Ag-doped SnSe is larger than that of Na-doped crystals due to the fact that the radius of Ag⁺ ions (1.26 Å) is larger than the radius of Na⁺ ions (0.97 Å).

Sample	a(Å)	b(Å)	c(Å)	Volume(Å ³)	
SnSe	11.4924	4.1513	4.4326	211.47	
Sn _{0.99} Ag _{0.01} Se	11.4953	4.1494	4.4390	211.74	
Sn _{0.98} Ag _{0.02} Se	11.4935	4.1501	4.4399	211.78	
Sn _{0.97} Ag _{0.03} Se	11.4957	4.1508	4.4386	211.79	
Sn _{0.99} Na _{0.01} Se	11.4969	4.1510	4.4322	211.52	
Sn _{0.98} Na _{0.02} Se	11.4993	4.1465	4.4337	211.40	
Sn _{0.97} Na _{0.03} Se	11.4975	4.1511	4.4352	211.70	

 Table S1. Lattice parameters derived from the powder XRD patterns.

The electronic transport properties

Table S2. Room temperature transport properties of $Sn_{1-x}R_xSe$ (R=Ag, Na; x=0, 0.01, 0.02,

0.03)

Sample	n_{H}	σ	Mobility	Seebeck	m*
	$(10^{17} \mathrm{cm}^{-3})$	(10^3S/m)	(cm ² /Vs)	$(\mu V/K)$	(m _e)
SnSe	4.45	1.07	150.3	431	0.12
Sn _{0.99} Ag _{0.01} Se	26.9	6.15	142.9	284	0.26
Sn _{0.98} Ag _{0.02} Se	71.5	16.1	139.8	237	0.42
Sn _{0.97} Ag _{0.03} Se	127	25.5	125.5	233	0.61
Sn _{0.99} Na _{0.01} Se	226	48.6	134.4	212	0.82
Sn _{0.98} Na _{0.02} Se	477	73.5	96.3	172	1.09
Sn _{0.97} Na _{0.03} Se	822	109	82.9	160	1.45

Room-temperature Hall coefficients were measured via a home-made apparatus in the applied field of ± 1 T. The band structure (see the main text in Figure 3) confirms the estimated values of effective mass calculated from the Seebeck coefficient at room temperature. The carrier concentration, carrier mobility and effective mass are roughly estimated by the single band model.



Figure S2. R_H/ρ for $Sn_{0.99}Na_{0.01}Se$ and $Sn_{0.98}Na_{0.02}Se$ crystals.

The thermal transport properties



Figure S3. Thermal diffusivity as a function of temperature for Sn_{1-x}R_xSe (R=Ag, Na; x=0.01, 0.02, 0.03)



Figure S4. The Lorenz number as a function of temperature for $Sn_{1-x}R_xSe$ (R=Ag, Na; x=0, 0.01, 0.02, 0.03), and the scattering factor r = -1/2

The Lorenz number depends on the degree of elasticity in carrier scattering, is defined as^{S1}

$$L = \left(\frac{k_B}{q}\right)^2 \left[\frac{\left(r + \frac{7}{2}\right)F_{r+\frac{5}{2}}(\eta)}{\left(r + \frac{5}{2}\right)F_{r+\frac{1}{2}}(\eta)} - \left(\frac{\left(r + \frac{5}{2}\right)F_{r+\frac{3}{2}}(\eta)}{\left(r + \frac{3}{2}\right)F_{r+\frac{1}{2}}(\eta)}\right)^2\right]$$
(S1)

with the Fermi integral

$$F_n(\eta) = \int_0^\infty \frac{\xi^n}{1 + e^{\xi - \eta}} d\xi$$
(S2)

where *r* is the scattering factor, which gives the exponent of the energy dependence on the charge carrier mean free path, η is the reduced Fermi energy from the Seebeck coefficient given by equation (S3).

(S3)

$$S = \mp \frac{k_B}{q} \left(\eta - \frac{\left(r + \frac{5}{2}\right)F_{r + \frac{3}{2}}(\eta)}{\left(r + \frac{3}{2}\right)F_{r + \frac{1}{2}}(\eta)} \right)$$

The thermal stability



Figure S5. The TE performance of $Sn_{0.97}Na_{0.03}Se$ single crystals during two heatingcooling cycle, indicating a very good thermal stability for the doped SnSe single

crystal.

Supplementary References

S1. T. Dahal, Q. Jie, Y. C. Lan, C. F. Guo and Z. F. Ren, *Phys Chem Chem Phys*, 2014, 16, 18170-18175.